

Notice of References Cited	Application/Control No. 10/527,797		Applicant(s)/Patent Under Reexamination TOMIZAWA ET AL.	
	Examiner John P. Sheehan		Art Unit 1742	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0098094 A1	05-2003	Hasegawa et al.	148/302
*	B	US-2002/0017338 A1	02-2002	Li, Gang	148/101
*	C	US-6,527,874 B2	03-2003	Li, Gang	148/301
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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